

TPIC2301 3-CHANNEL COMMON-SOURCE POWER DMOS ARRAY

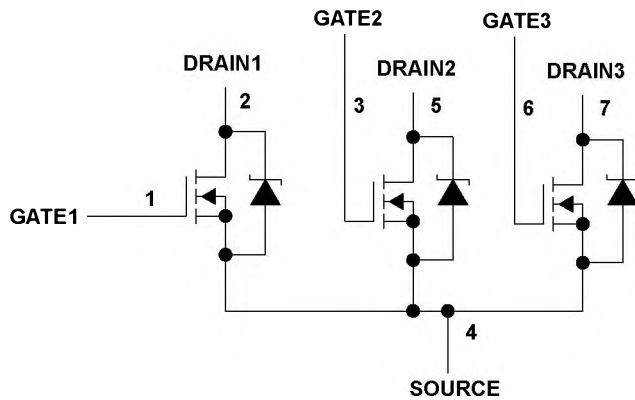
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- Three 7.5-A Independent Output Channels, Continuous Current Per Channel
- Low $r_{DS(on)}$. . . 0.09 Ω Typical
- Output Voltage . . . 60 V
- Pulsed Current . . . 15 A Per Channel
- Avalanche Energy . . . 120 mJ

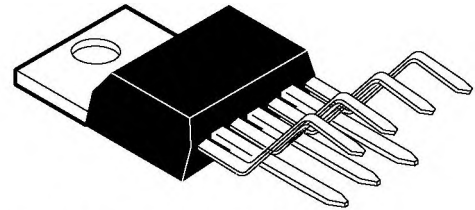
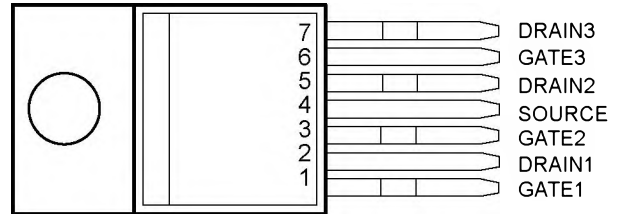
description

The TPIC2301 is a monolithic power DMOS array that consists of three independent N-channel enhancement-mode DMOS transistors connected in a common-source configuration with open drains.

schematic



KV PACKAGE
(TOP VIEW)



The tab is electrically connected to SOURCE.

absolute maximum ratings over operating case temperature range (unless otherwise noted)

| | |
|---|--|
| Drain-source voltage, V_{DS} | 60 V |
| Gate-source voltage, V_{GS} | ± 20 V |
| Continuous source-drain diode current | 7.5 A |
| Pulsed drain current, each output, all outputs on, I_D (see Note 1) | 15 A |
| Continuous drain current, each output, all outputs on | 7.5 A |
| Single-pulse avalanche energy, E_{AS} (see Figure 4) | 120 mJ |
| Continuous power dissipation at (or below) $T_A = 25^\circ\text{C}$ (see Note 2) | 2 W |
| Continuous power dissipation at (or below) $T_C = 75^\circ\text{C}$, all outputs on (see Note 2) | 50 W |
| Operating virtual junction temperature range, T_J | -40°C to 150°C |
| Operating case temperature range, T_C | -40°C to 125°C |
| Storage temperature range, T_{stg} | -40°C to 125°C |
| Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds | 260°C |

- NOTES: 1. Pulse duration = 10 ms, duty cycle = 6%
2. For operation above 25°C free-air temperature, derate linearly at the rate of 16 mW/ $^\circ\text{C}$. For operation above 75°C case temperature, and with all outputs conducting, derate linearly at the rate of 0.66 W/ $^\circ\text{C}$. To avoid exceeding the design maximum virtual junction temperature, these ratings should not be exceeded.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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electrical characteristics, $T_C = 25^\circ\text{C}$ (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|--|---------------------------|------|-------|---------------|
| $V_{(BR)DS}$ Drain-source breakdown voltage | $I_D = 1\ \mu\text{A}$, $V_{GS} = 0$ | 60 | | | V |
| V_{TGS} Gate-source threshold voltage | $I_D = 1\ \text{mA}$, $V_{DS} = V_{GS}$ | 1.2 | 1.75 | 2.4 | V |
| $V_{DS(on)}$ Drain-source on-state voltage | $I_D = 7.5\ \text{A}$, $V_{GS} = 15\ \text{V}$, See Notes 3 and 4 | | 0.68 | 0.94 | V |
| I_{DSS} Zero-gate-voltage drain current | $V_{DS} = 48\ \text{V}$, $V_{GS} = 0$ | $T_C = 25^\circ\text{C}$ | 0.07 | 1 | μA |
| | | $T_C = 125^\circ\text{C}$ | 1.3 | 10 | |
| I_{GSSF} Forward gate current, drain short circuited to source | $V_{GS} = 20\ \text{V}$, $V_{DS} = 0$ | | 10 | 100 | nA |
| I_{GSSR} Reverse gate current, drain short circuited to source | $V_{GS} = -20\ \text{V}$, $V_{DS} = 0$ | | 10 | 100 | nA |
| $r_{DS(on)}$ Static drain-source on-state resistance | $V_{GS} = 15\ \text{V}$, $I_D = 7.5\ \text{A}$, See Notes 3 and 4 and Figures 5 and 6 | $T_C = 25^\circ\text{C}$ | 0.09 | 0.125 | Ω |
| | | $T_C = 125^\circ\text{C}$ | 0.15 | 0.21 | |
| g_{fs} Forward transconductance | $V_{DS} = 15\ \text{V}$, $I_D = 5\ \text{A}$, See Notes 3 and 4 | 3.3 | 4.7 | | S |
| C_{iss} Short-circuit input capacitance, common source | $V_{DS} = 25\ \text{V}$, $V_{GS} = 0$, $f = 300\ \text{kHz}$ | | 490 | | pF |
| C_{oss} Short-circuit output capacitance, common source | | | 285 | | |
| C_{rss} Short-circuit reverse transfer capacitance, common source | | | 90 | | |

NOTES: 3. Technique should limit $T_J - T_C$ to 10°C maximum.

4. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

source-drain diode characteristics, $T_C = 25^\circ\text{C}$

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|--|-----|-----|-----|---------------|
| V_{SD} Forward on voltage | $I_S = 7.5\ \text{A}$, $V_{GS} = 0$, $V_{DS} = 48\ \text{V}$, See Figure 1 | | 0.8 | 1.3 | V |
| t_{rr} Reverse recovery time | | | 200 | | ns |
| Q_{RR} Total source-drain diode charge | | | 1.5 | | μC |

resistive-load switching characteristics, $T_C = 25^\circ\text{C}$

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|----------------------------------|--|-----|------|-----|------|
| $t_{d(on)}$ Turn-on delay time | $V_{DD} = 25\ \text{V}$, $R_L = 6.7\ \Omega$, $t_{en} = 10\ \text{ns}$, $t_{dis} = 10\ \text{ns}$, See Figure 2 | | 12 | | ns |
| $t_{d(off)}$ Turn-off delay time | | | 100 | | |
| t_r Rise time | | | 43 | | |
| t_f Fall time | | | 5 | | |
| Q_g Total gate charge | $V_{DS} = 48\ \text{V}$, $I_D = 2.5\ \text{A}$, $V_{GS} = 10\ \text{V}$, See Figure 3 | | 13.6 | 18 | nC |
| Q_{gs} Gate-source charge | | | 8.3 | 11 | |
| Q_{gd} Gate-drain charge | | | 5.3 | 7 | |
| L_D Internal drain inductance | | | 7 | | nH |
| L_S Internal source inductance | | | 7 | | |

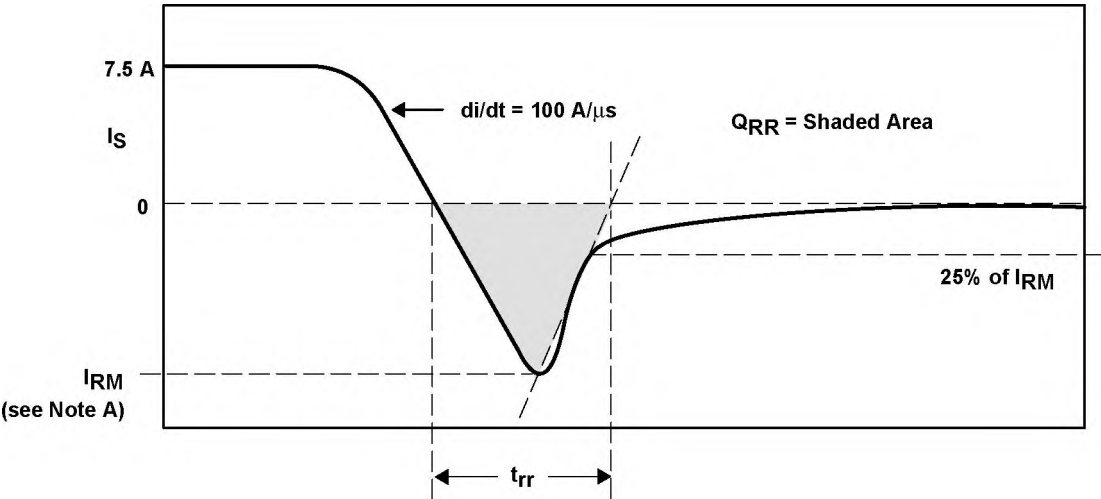
thermal resistance

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|------------------------------|-----|-----|------|---------------------------|
| $R_{\theta JA}$ Junction-to-ambient thermal resistance | All outputs with equal power | | | 62.5 | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JC}$ Junction-to-case thermal resistance | All outputs with equal power | | | 1.5 | $^\circ\text{C}/\text{W}$ |
| | One output dissipating power | | | 3.3 | $^\circ\text{C}/\text{W}$ |



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PARAMETER MEASUREMENT INFORMATION



NOTE A: I_{RM} = maximum recovery current

Figure 1. Reverse-Recovery-Current Waveforms of Source-Drain Diode

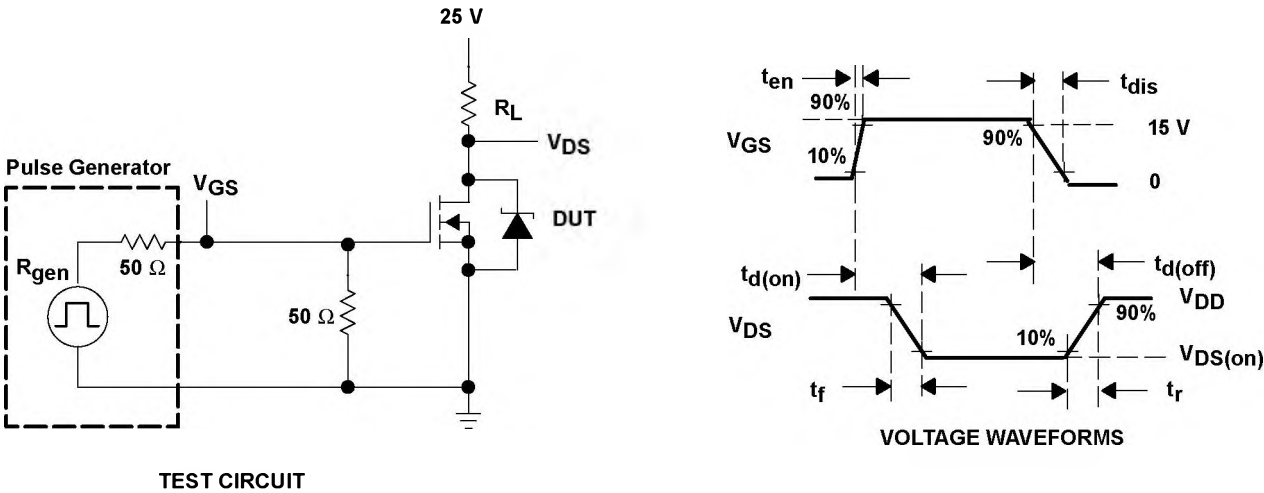


Figure 2. Resistive Switching

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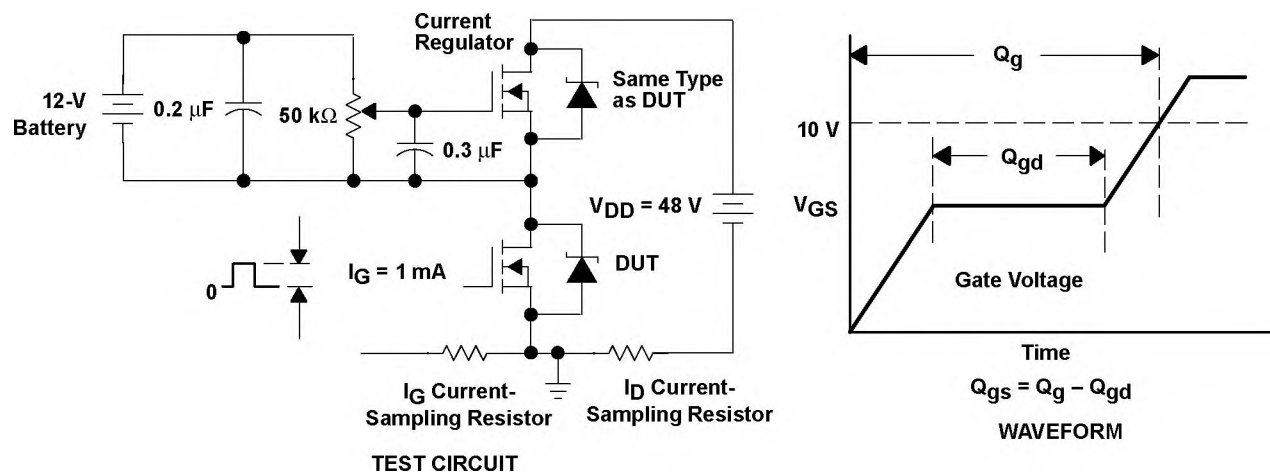
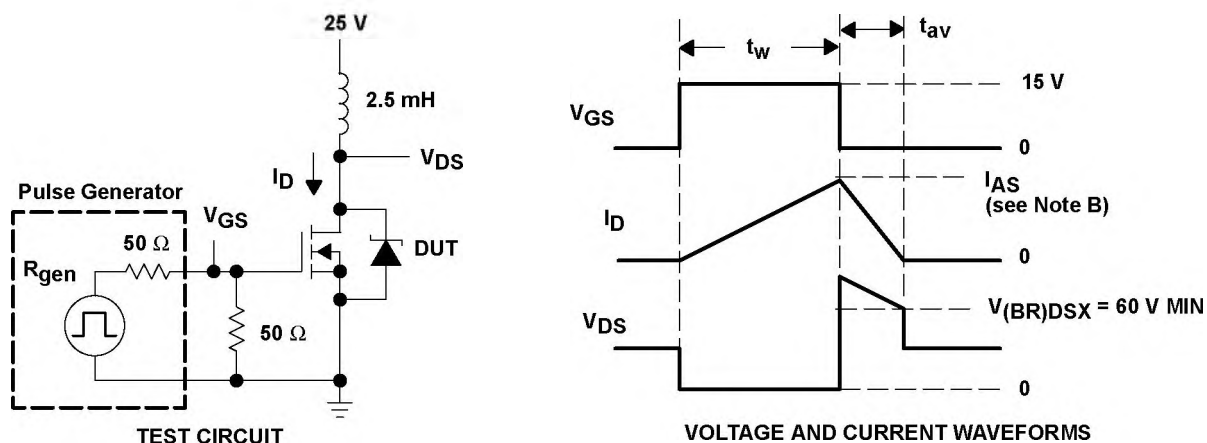


Figure 3. Gate-Charge Test Circuit and Waveform



NOTES: A. The pulse generator has the following characteristics: $t_r \leq 10 \text{ ns}$, $t_f \leq 10 \text{ ns}$, $Z_O = 50 \Omega$.
B. Input pulse duration (t_w) is increased until peak current $I_{AS} = 7.5 \text{ A}$.

Figure 4. Single-Pulse Avalanche Energy Test Circuit and Waveforms

TYPICAL CHARACTERISTICS

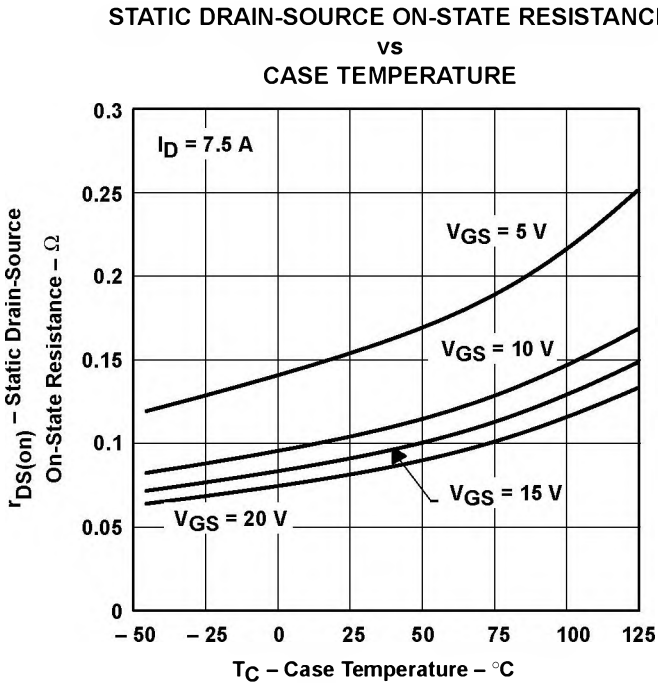


Figure 5

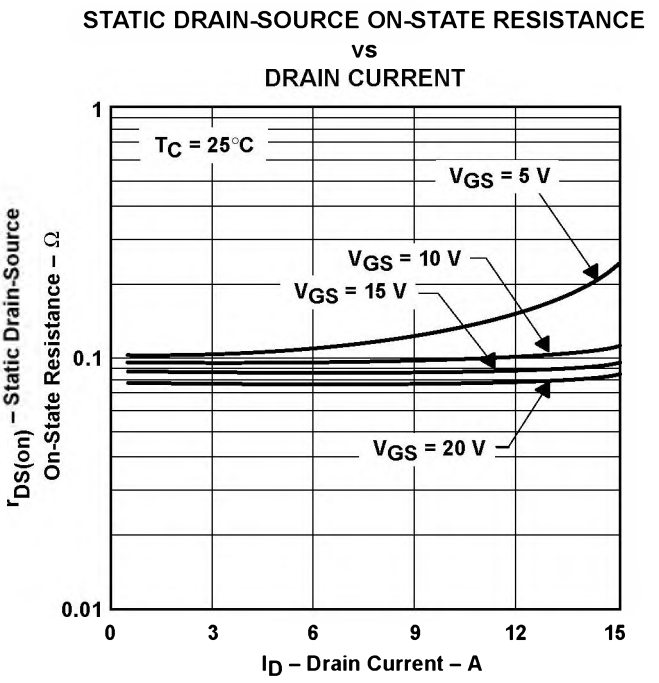


Figure 6

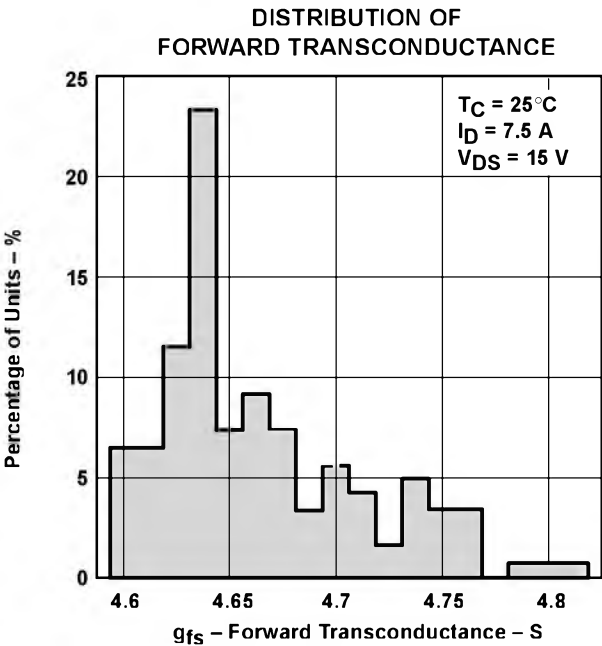


Figure 7

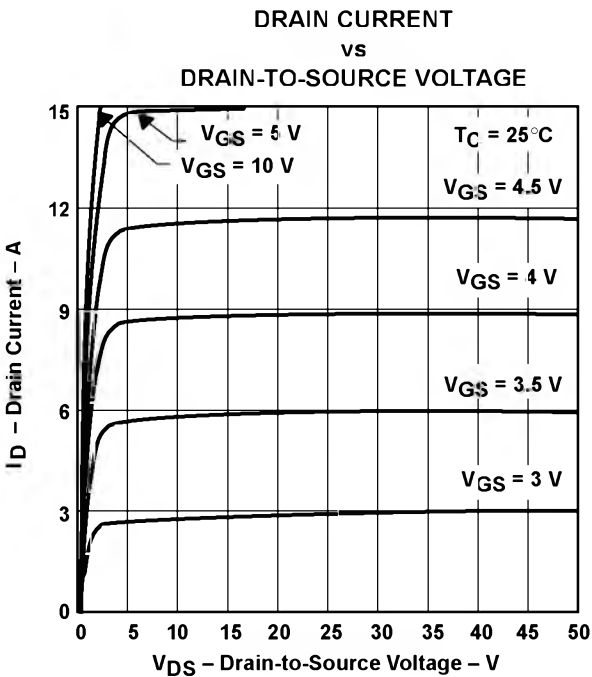


Figure 8

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TYPICAL CHARACTERISTICS

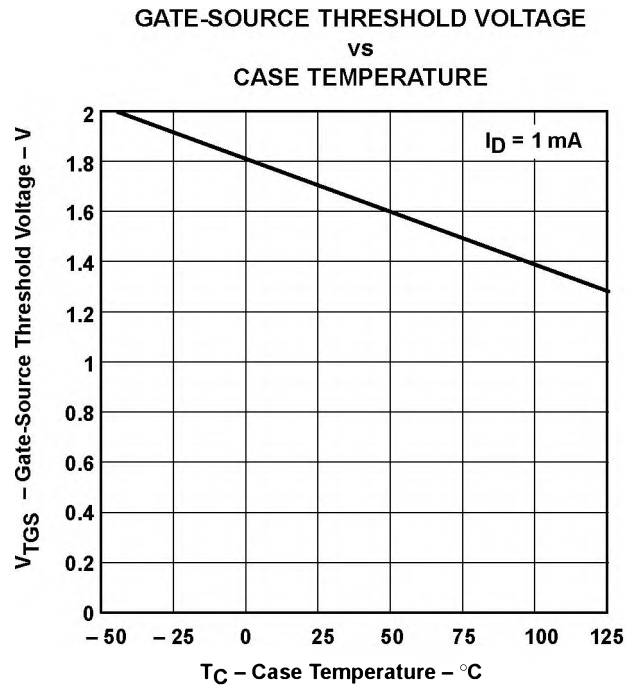


Figure 9

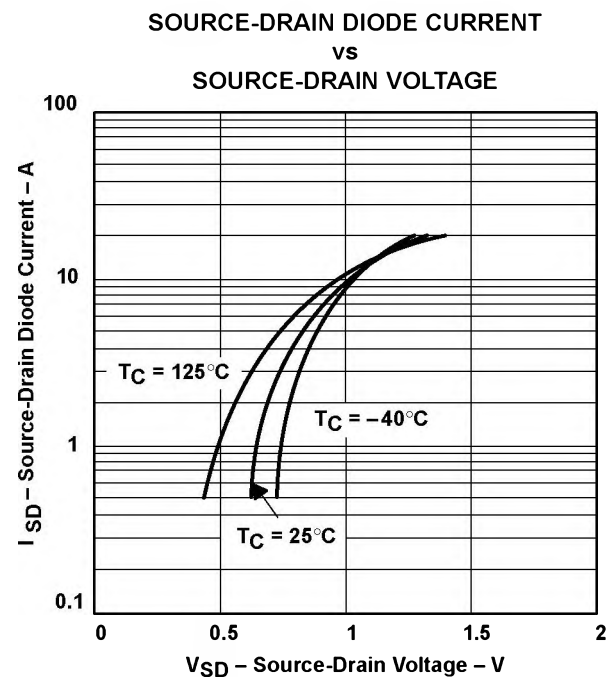


Figure 10

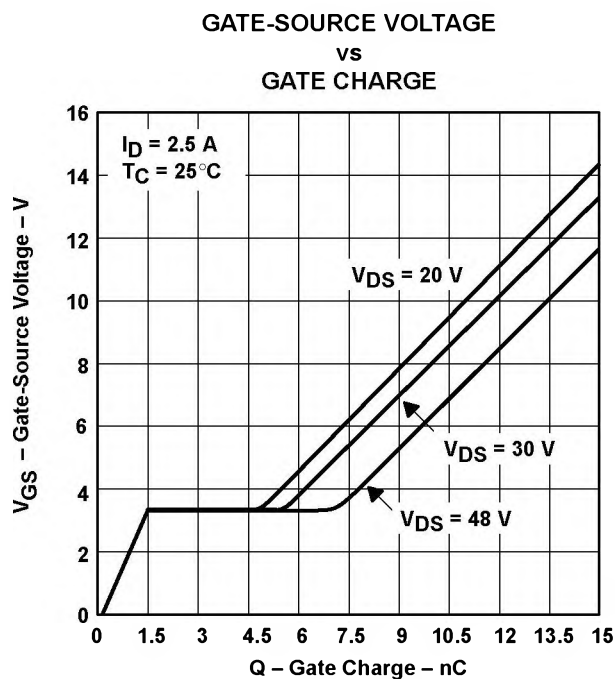


Figure 11

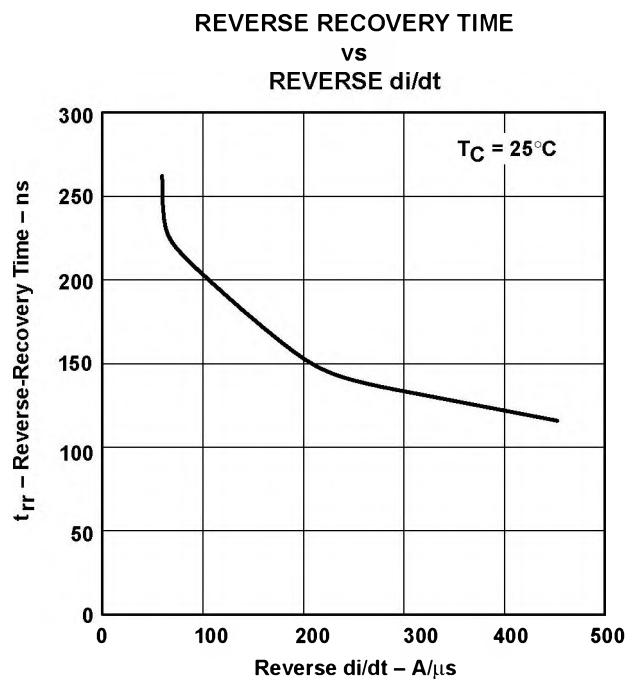
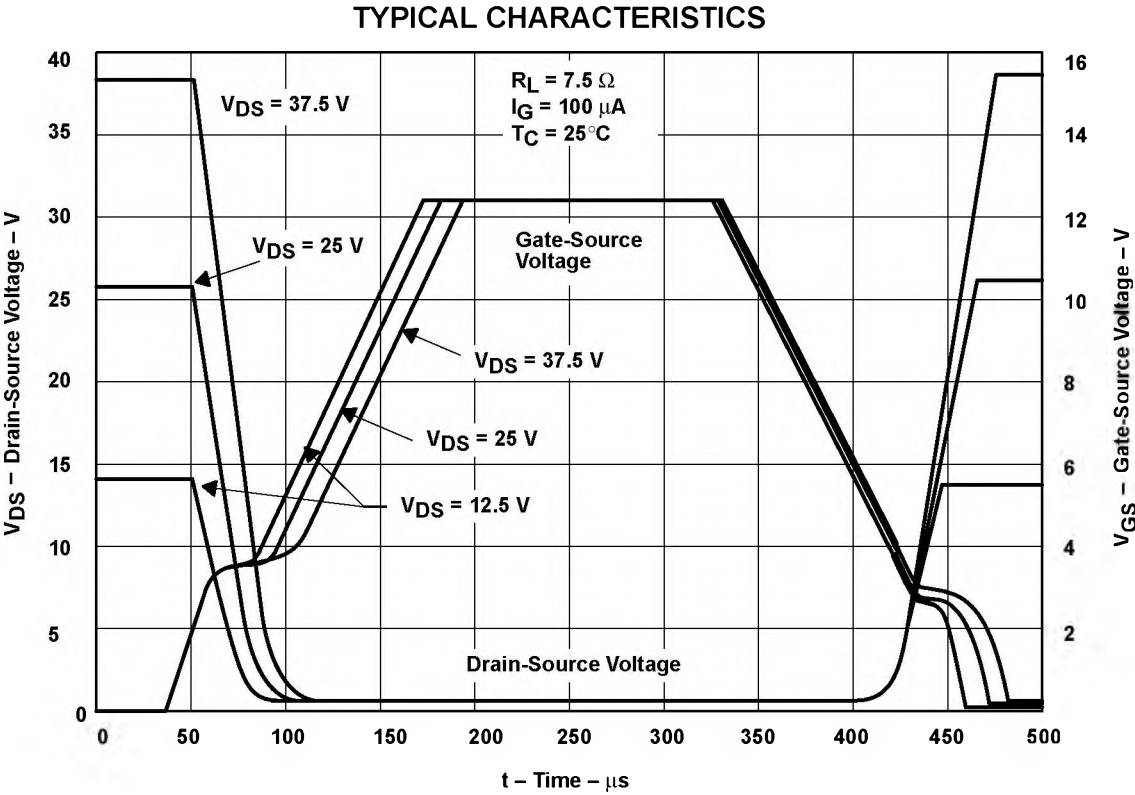


Figure 12



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THERMAL INFORMATION

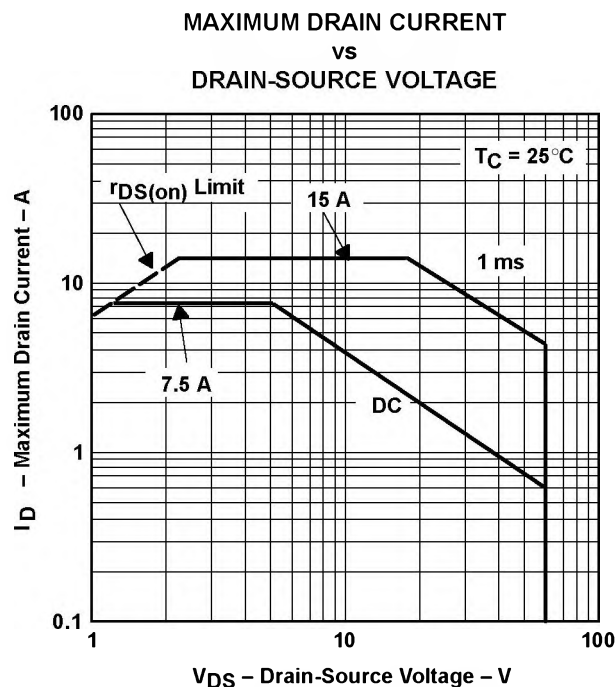


Figure 14

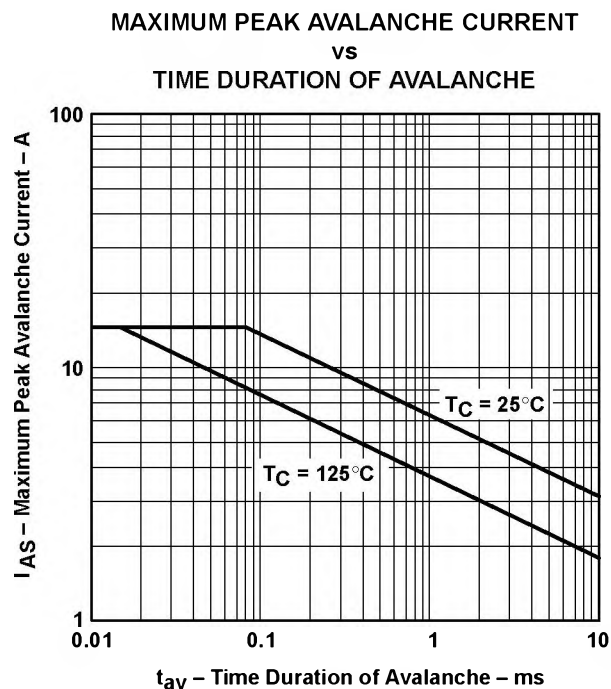
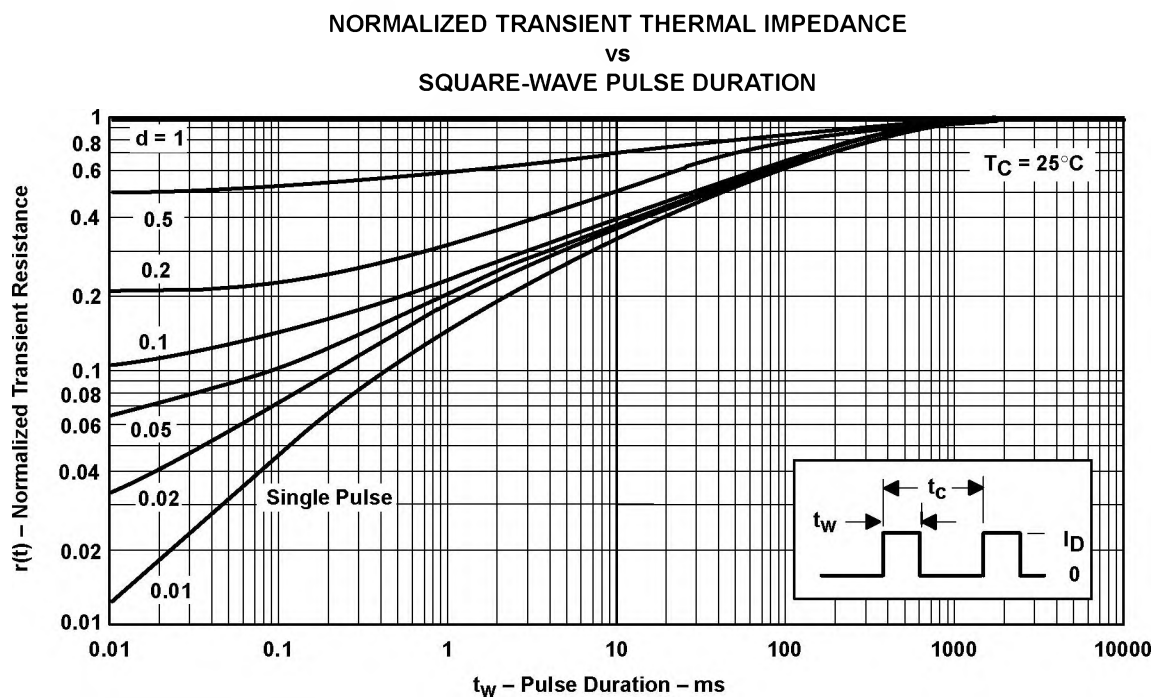


Figure 15



NOTES: $Z_{\theta JC}(t) = r(t) R_{\theta JC}$
 t_W = pulse duration
 t_C = period
 d = duty cycle = t_W/t_C

Figure 16

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